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INFORMATION DISCLOSURE
STATEMENT BY APPLICANT APPLI

(use as many sheets as necessary)

Sheet

Complete If Known

Application Number 10/565,519

Filing Date January 23, 2006

First Named Inventor Johannes Benedikt

Group Art Unit Named Inventor Accepted Arry He

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Exam. Initials* ,	Cite No. ¹	U.S. Patent Document		Name of Patentee	Date of Pub.	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures
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Exam. Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
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